

**Search Notes****Application/Control No.**

09/751,429

**Examiner**

Phallaka Kik

**Applicant(s)/Patent under Reexamination**

REINSCHMIDT ET AL.

**Art Unit**

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	9,10,13,14	9/13/2005	PK
700	115,221	9/13/2005	PK
700	226	9/13/2005	PK
326	41,47,101	9/13/2005	PK
Above	Updated	2/22/2006	PK
Above	New	2/22/2006	PK
716	19,21	2/22/2006	PK
Above	updated	2/27/2006	PK
Above	new	2/27/2006	PK
257	758	2/27/2006	PK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	9,10,13	2/27/2006	PK
716	14,19	2/27/2006	PK
700	115	2/27/2006	PK
257/758 --USPGPUB (see attached)	2/27/2006	PK	

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Cl/sub Searched: 716/1-21; 700/115-116,221-222,224- 227, 326/38-50,101-103; 438/6-10 (see attach)	9/13/2005	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	9/13/2005	PK
All above updated and new search (see attached)	2/22/2006	PK
Updated and new search: BRS (EAST) --USPAT, USGPUB Additional cl/sub searched: 257/758, e23.179 (see attached)	2/27/2006	PK
IEE/IEEE Xplore (see attached)	9/13/2005	PK
IEE/IEEE Xplore (see attached)	2/22/2006	PK
Consulted with Examiner Nathan W. Ha --case does not belong in 257 but may cross-ref. to 257/758	2/26/2006	PK
Consulted with Examiner Vibol Tan --no cross-ref. to 326; check with 257	2/24/2006	PK

<b>Search Notes (continued)</b>	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/751,429	REINSCHMIDT ET AL.
Examiner	Art Unit	
Phallaka Kik	2825	

**SEARCHED**